Scientific Publications X-Ray Optics Group past 10 years

Last updated: December 2017

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1. M. Lebugle, G. Seniutinas, F. Marschall, V.A. Guzenko, D. Grolimund, and C. David
A tunable kinoform X ray beamsplitter
Optics Letters **42** (2017) p. 4327-4330

2. B. Rösner, F. Döring, P.R. Riberič, D. Gauthier, E. Principi, C. Masciovecchio, M. Zangrando, J. Vila-Comamala, G. De Ninno, and C. David
High Resolution Beam Profiling of X-ray Free Electron Laser Radiation by Polymer Imprint Development
Optics Express **25** (2017) p. 30686-30695

3. F. Marschall, Z. Yin, J. Rehanek, M. Beye, F. Döring, K. Kubicek, D. Raiser, S. Thekku Veedu, J. Buck, A. Rothkirch, B. Rösner, V.A. Guzenko, J. Viefhaus, C. David, and S. Techert
Transmission zone plates as analyzers for efficient RIXS-mapping
Scientific Reports **7** (2017) p. 8849-7, DOI: 10.1038/s41598-017-09052-0

4. P.R. Ribič, B. Rösner, D. Gauthier, E. Allaria, F. Döring, L. Foglia, L. Giannessi, N. Mahne, M. Manfredda, C. Masciovecchio, R. Mincigrucci, N. Mirian, E. Principi, E. Roussel, A. Simoncig, S. Spampinati, C. David, G. De Ninno
Extreme Ultraviolet Vortices from a Free Electron Laser
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7. I. Greving, M. Ogurreck, F. Marschall, A. Last, F. Wilde, T. Dose, H. Burmester, L. Lottermoser, M. Müller, C. David and F. Beckmann,
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8. M. Buzzi, M. Makita, L. Howald, A. Kleibert, B. Vodungbo, P. Maldonado, J. Raabe, N. Jaouen, H. Redlin, K. Tiedtke, P.M. Oppeneer, C. David, F. Nolting, J. Lüning
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9. N. Opara, S. Arnold, T. Braun, H. Stahlberg, M. Makita, C. David, and C. Padeste,
Direct protein crystallization on ultrathin membranes for diffraction measurements at X-ray free electron lasers
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13. B. Pedrini, A. Menzel, V.A. Guzenko, C. David, R. Abela, C. Gutt
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17. M. Makita, P. Karvinen, V.A. Guzenko, P. Vagovic, C. David
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18. Y. Kayser, C. David, U. Flechsig, J. Krempasky, V. Schlott and R. Abela
X-ray grating interferometer for in-situ and at-wavelength wavefront metrology
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